

Notice of References Cited	Application/Control No. 09/776,057	Applicant(s)/Patent Under Reexamination SESEK, ROBERT	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,189,103 B1	02-2001	Nevarez et al.	713/201
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